

**Search Notes**

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Examiner

Tae H. Yoon

Applicant(s)/Patent under  
Reexamination

BAUER ET AL.

Art Unit

1714

**SEARCHED**

Class	Subclass	Date	Examiner
524	437	3/17/07	2

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	3/17/07	2
ZAST	3/12/07	2